## Application/Control No. Applicant(s)/Patent Under Reexamination 10/676,208 WEN ET AL. **Notice of References Cited** Examiner Art Unit Page 1 of 1 Edna Wong 1753 **U.S. PATENT DOCUMENTS Document Number** Date Country Code-Number-Kind Code Name Classification MM-YYYY US-6,534,863 03-2003 Walker et al. Α 257/737 \* US-2003/0176064 09-2003 438/687 В Lu et al. С US-US-D Ε US-F US-US-G Н US-US-Ì US-US-Κ US-US-M **FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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